Docket No.

239708US2S

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Fumitaka ARAI, et al.

SERIAL NO: New Application

GAU:

FILED:

Herewith

EXAMINER:

FOR:

NON-VOLATILE SEMICONDUCTOR STORAGE DEVICE COMPOSED OF NAND TYPE EEPROM AND DELETION VERIFICATION METHOD IN NON-VOLATILE SEMICONDUCTOR STORAGE DEVICE

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- ☐ A check is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- A check is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

Marvin J. Spivak

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Form PTO 1449 U.S. DEPARTMENT OF COMMERCE				ATTY DOCKET NO.		SERIAL NO.		
(Modified) PATENT AND TRADEMARK OFFICE			239708US2S		New Application			
				APPLICANT				
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Fumitaka ARAI, et al.				
				FILING DATE		GROUP		
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U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
1	AA	6,314,026 B1	11/06/01	Shinji SATOH, et al.	No. 20			
	AB	6,459,612 B2	10/01/02	Shinji SATOH, et al.				
	AC	6,493,265 B2	12/10/02	Shinji SATOH, et al.				
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	AG	6,549,464 B2	04/15/03	Tomoharu TANAKA, et al.	ļ			
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	AP	7-161852	06/23/95	Japan			X	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
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	АХ	· ·						
	AY							
	AZ				Add	itional Refe	erences sheet(s) attached	
Examiner					Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								